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Control of Mg content and carrier concentration via post annealing under different Mg partial pressures for Sb-doped Mg₂Si thermoelectric material

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Abstract

An approach to control the Mg content in Sb-doped Mg₂Si via post annealing under different Mg partial pressures is developed. Annealing under low and high Mg partial pressures ($\leq 1 \times 10^{-1}$ Pa and 1×10^1 Pa) result in low and high carrier concentrations of Mg₂Si_{0.99}Sb_{0.01} (1.2×10^{20} cm⁻³ and 1.7×10^{20} cm⁻³) that correspond to a hypo-stoichiometric and a hyper-stoichiometric compositions, respectively. Mg₂Si_{0.99}Sb_{0.01} with a hypo-stoichiometric composition shows a low figure of merit below 573 K mainly due to a reduction of the carrier mobility probably by the carrier scattering at Mg-deficient grain boundaries. The carrier mobility and the figure of merit are recovered by increasing the Mg content via annealing under high Mg partial pressure, which indicates that the annealing process is an effective way to recover the thermoelectric performance of Mg-deficient Mg₂Si-based materials.

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